	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10781757	HIRAO, TETSUHIRO
	Examiner	Art Unit
	Vy, Hung T	2163

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	ORIGINAL	AAL	Z	ERNATIONAL	INTERNATIONAL CLASSIFICATION	
	CLASS	SUBCLASS	CLAIMED	٥	NON-CLAIMED	AIMED
707		102	G 0 6 F	17 / 30		
,	CROSS REFERENCE(S)	RENCE(S)	9 0	12 / 00		
			G 0 6 F	12 / 10		
CLASS	SUBCLASS (OI	SUBCLASS (ONE SUBCLASS PER BLOCK)				
707	200					
711	206					
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(Assistant Examiner)	niner) (Date)		Ç		+	12
AIL	8 H 1210M		ON WONG EXAMINATION OF OTHER		O.G. Print Claim(s)	O.G. Print Figure
(Legal Instruments Examiner)		(Primary Examiner)	PAILE (Date)	6/11/01	-	80
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